

Docket No.: 050432-0601 **PATENT** 

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Application of : Customer Number: 20277

Minh Van NGO, et al. : Confirmation Number: 3500

Application No.: 10/617,451 : Group Art Unit: 2812

Filed: July 11, 2003 : Examiner: LINDSAY, Walter Lee Jr.

For: PECVD SILICON-RICH OXIDE LAYER FOR REDUCED UV CHARGING

## INFORMATION DISCLOSURE STATEMENT

Mail Stop Commissioner for Patents P.O. Box 1450 Alexandria, VA 22313-1450

Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached form PTO-1449. It is respectfully requested that the references be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed within three months of the U.S. filing date OR before the mailing date of a first Office Action on the merits. No certification or fee is required.

Each English language reference was cited in a corresponding foreign application search report or office action and its relevance discussed therein. A copy of the foreign search report or office action is attached for the Examiner's information. Please note that copies of U.S. Patent

## 10/617,451

Nos. 5,290,727 and 5,602,056, which were cited in January 11, 2005 International Search Report, are not enclosed as they were submitted with the Information Disclosure Statement filed April 15, 2005.

Please charge any shortage in fees due in connection with the filing of this paper, including extension of time fees, to Deposit Account 500417 and please credit any excess fees to such deposit account.

Respectfully submitted,

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Please recognize our Customer No. 20277 as our correspondence address.

SHEET <u>1</u> OF <u>1</u>

INFORMATION DISCLOSURE CITATION IN AN APPLICATION						ATTY. DOCKET NO. <b>050432-0601</b>		SERIAL NO. 10/617,451				
						APPLICANT Minh Van NGO, et al.						
(PTO-1449)						FILING DATE GRO <b>July 11, 2003</b> 28			OUP 1 <b>12</b>			
U.S. PATENT DOCUMENTS												
EXAMINER'S INITIALS	CITE NO.	Document Number Number-Kind Code2 (# known)		Publication Dat MM-DD-YYYY		Name of Patentee or Applicant of Cited Document			Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
		US	5,290,727	03/01/94		Jain et al.						
		US	5,602,056	02/11/97		Jain et al.						
		US	2003/096476 A1	05/22/03	_	Bloom et al.						
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OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.)												
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EXAMINER						DATE CONSIDERED						

<sup>\*</sup>EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

1 Applicant's unique citation designation number (optional). 2 Applicant is to place a check mark here if English language Translation is attached.